

General Description

The Sanrise SRC60R075BS is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and outstanding efficiency.

The SRC60R075BS break down voltage is 600V and it has a high rugged avalanche characteristics. The SRC60R075BS is available in PDFN8*8 package.

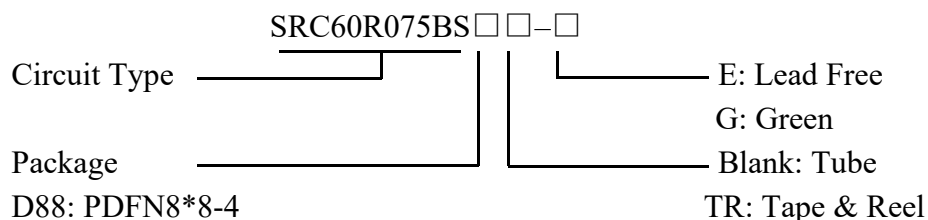
Features

- Ultra Low $R_{DS(ON)} = 75m\Omega @ V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g = 110nC$ typ.
- Fast switching capability
- Robust design with better EAS performance
- EMI Improved
- Non-automotive Qualified

Application

- Telecom Power
- EV Charger
- High Power Application

Ordering Information



Symbol

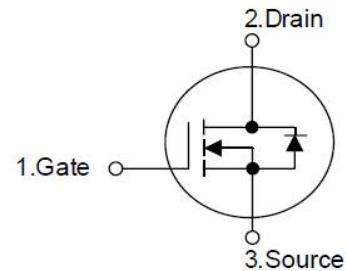
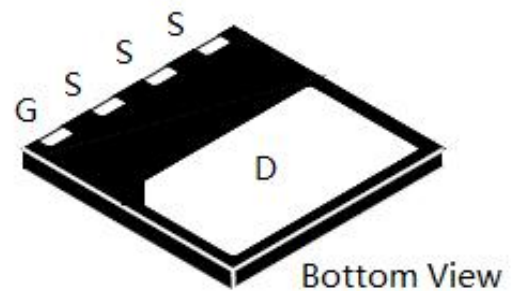


Figure 1 Symbol of SRC60R075BS

Package Type



PDFN8*8-4

Figure 2 Package Type of SRC60R075BS

Package	Part Number	Marking ID	Packing Type
PDFN8*8-4	SRC60R075BSD88TR-G	SRC60R075BSD88G	Tape & Reel

Absolute Maximum Ratings^{Note 1}

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage (static)		V_{GSS}	±20	V
Gate-Source Voltage (dynamic), AC ($f > 1$ Hz)		V_{GSS}	±30	V
Power Dissipation ($T_C=25^\circ\text{C}$, PDFN8*8-4)		P_{tot}	357.1	W
Continuous Drain Current	$T_C=25^\circ\text{C}$	I_D	48	A
	$T_C=100^\circ\text{C}$		30.3	
	$T_C=125^\circ\text{C}$		21.5	
Pulsed Drain Current (Note 2)		I_{DM}	144	A
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	125	mJ
Avalanche Energy, Repetitive (Note 2)		E_{AR}	0.6	mJ
Avalanche Current, Repetitive (Note 2)		I_{AR}	5.0	A
Continuous Diode Forward Current		I_S	48	A
Diode Pulse Current		$I_{S,PULSE}$	144	A
MOSFET dv/dt Ruggedness, $V_{DS} \leq 480\text{V}$		dv/dt	80	V/ns
Reverse Diode dv/dt, $V_{DS} \leq 480\text{V}$, $I_{SD} \leq I_D$		dv/dt	50	V/ns
Power Dissipation ($T_C=25^\circ\text{C}$)		P_{tot}	357	W
Operating Junction Temperature		T_J	150	°C
Storage Temperature		T_{STG}	-55 to 150	°C
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	°C

Note:

- Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
- Repetitive Rating: Pulse width limited by maximum junction temperature
- $I_{AS} = 5\text{A}$, $V_{DD} = 60\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

Thermal characteristics

Parameter		Symbol	Min	Typ	Max	Unit
Thermal resistance, Junction-to-Case	PDFN8*8-4	R_{thJC}			0.35	°C/W
Thermal resistance, Junction-to-Ambient	PDFN8*8-4	R_{thJA}			58	°C/W

Electrical Characteristics
 $T_J = 25^{\circ}\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			10	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-30V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=5.0mA$	3.7	4.3	5.3	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=24A$		65	75	mΩ
Gate Resistance	R_G	f=1MHz, Open Drain	0.11	0.55	5.0	Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=25V, V_{GS}=0V, f=1MHz$	2.6	4.32	6.6	nF
Output Capacitance	C_{OSS}		1	2.8	8	nF
Reverse Transfer Capacitance	C_{RSS}		10	33	300	pF
Effective output capacitance, energy related ^{NOTE5}	$C_{O(er)}$	$V_{GS}=0V, V_{DS}=0\dots 400V$		94		pF
Effective output capacitance, time related ^{NOTE6}	$C_{O(tr)}$			550		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=24A, R_G=3.3\Omega, V_{GS}=10V$		16		ns
Rise Time	t_r			6.0		
Turn-off Delay Time	$t_{d(off)}$			98		
Fall Time	t_f			4.0		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=480V, I_D=24A, V_{GS}=0 \text{ to } 10V$		28.1		nC
Gate to Drain Charge	Q_{gd}			56.0		
Gate Charge Total	Q_g			110	160	
Gate Plateau Voltage	$V_{plateau}$			6.5		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=24A$		0.9	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=400V, I_F=24A, dI_F/dt=100A/\mu s$		141	200	ns
Reverse Recovery Charge	Q_{rr}			0.83	1.66	μC
Peak Reverse Recovery Current	I_{rrm}			11.8		A

Note:

 5. $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 480V

 6. $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 480 V



Shenzhen Sanrise Technology Co., LTD

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